

## Features

- 600 V, 30 A, Low Collector-Emitter Saturation Voltage (V<sub>CE(sat)</sub>)
- Trench-Gate Field-Stop technology

BIDW30N60T Insulated Gate Bipolar Transistor (IGBT)

- Optimized for conduction
- RoHS compliant\*

## **Applications**

- Switch-Mode Power Supplies (SMPS)
- Uninterruptible Power Sources (UPS)
- Power Factor Correction (PFC)
- Induction heating

### **General Information**

The Bourns® Model BIDW30N60T IGBT device combines technology from a MOS gate and a bipolar transistor for an optimum component for high voltage and high current applications. This device uses Trench-Gate Field-Stop technology providing greater control of dynamic characteristics with a lower Collector-Emitter Saturation Voltage (V<sub>CE(sat)</sub>) and fewer switching losses. In addition, this structure gives a lower thermal resistance R<sub>(th)</sub>.

### **Additional Information**

Click these links for more information:



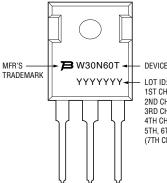
## Maximum Electrical Ratings (T<sub>C</sub> = 25 °C, unless otherwise specified)

Parameter	Symbol	Value	Unit
Collector-Emitter Voltage	V <sub>CES</sub>	600	V
Continuous Collector Current (T <sub>C</sub> = 25 °C), limited by $T_{jmax}$	Ι <sub>C</sub>	60	А
Continuous Collector Current (T <sub>C</sub> = 100 °C), limited by $T_{jmax}$	Ι <sub>C</sub>	30	А
Pulsed Collector Current, tp limited by Tjmax	I <sub>CP</sub>	90	А
Gate-Emitter Voltage	V <sub>GE</sub>	±20	V
Continuous Forward Current (T <sub>C</sub> = 25 °C), limited by $T_{jmax}$	IF	60	А
Continuous Forward Current (T <sub>C</sub> = 100 °C), limited by T <sub>jmax</sub>	IF	30	А
Short-circuit Withstand Time ( $V_{CE}$ = 300 V, $V_{GE}$ = 15 V)	T <sub>SC</sub>	10	μs
Total Power Dissipation	P <sub>total</sub>	230	W
Storage Temperature	T <sub>STG</sub>	-55 to +150	°C
Operating Junction Temperature	Tj	-55 to +150	°C

#### **Thermal Resistance**

Parameter	Symbol	Мах	Unit
IGBT Thermal Resistance Junction - Case	R <sub>th(j-c)_IGBT</sub>	0.54	°C/W
Diode Thermal Resistance Junction - Case	R <sub>th(j-c)_Diode</sub>	1.2	°C/W

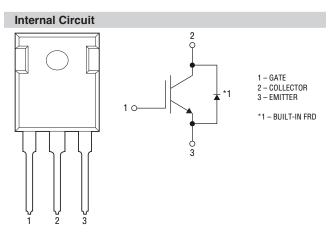
#### **Typical Part Marking**



WARNING Cancer and

**Reproductive Harm** 

DEVICE CODE I OT ID: 1ST CHARACTER INDICATES PRODUCTION LINE 2ND CHARACTER INDICATES GRADE 3RD CHARACTER INDICATES YEAR OF MANUFACTURE 4TH CHARACTER INDICATES MONTH OF MANUFACTURE 5TH, 6TH & 7TH CHARACTERS INDICATE SERIAL NO. (7TH CHARACTER COULD BE OMITTED)



\*RoHS Directive 2015/863, Mar 31, 2015 and Annex.

Specifications are subject to change without notice.

Users should verify actual device performance in their specific applications.

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### Static Electrical Characteristics (T<sub>C</sub> = 25 °C, Unless Otherwise Specified)

Parameter	Symbol	Conditions	Value			Unit
Farameter			Min.	Тур.	Max.	onn
Collector-Emitter Breakdown Voltage	BV <sub>CES</sub>	$V_{GE}$ = 0 V, $I_C$ = 250 $\mu$ A	600	—	—	V
Collector-Emitter Saturation Voltage	V <sub>CE(sat)</sub>	$V_{GE} = 15 \text{ V}, I_{C} = 30 \text{ A}$ $T_{C} = 25 \text{ °C}$	_	1.65	_	v
		$V_{GE} = 15 \text{ V}, I_{C} = 30 \text{ A}$ $T_{C} = 125 \text{ °C}$	_	1.9	_	
Diada Famuard On Valtage	V <sub>F</sub>	I <sub>F</sub> = 30 A, T <sub>C</sub> = 25 °C	_	1.8	_	V
Diode Forward On-Voltage		I <sub>F</sub> = 30 A, T <sub>C</sub> = 125 °C	_	1.5	_	V
Gate Threshold Voltage	V <sub>GE(th)</sub>	$V_{CE} = V_{GE}, I_C = 250 \ \mu A$	4.0	5.0	6.5	V
Collector Cut-off Current	ICES	$V_{GE} = 0 V, V_{CE} = 600 V$	_	_	200	μA
Gate-Emitter Leakage Current	I <sub>GES</sub>	$V_{CE} = 0 V, V_{GE} = \pm 20 V$	—	—	±400	nA

### Dynamic Electrical Characteristics (T<sub>C</sub> = 25 °C, Unless Otherwise Specified)

Parameter	Ormitest	Conditions	Value			11-24
	Symbol		Min.	Тур.	Max.	Unit
Input Capacitance	C <sub>ies</sub>	V <sub>CE</sub> = 30 V, V <sub>GE</sub> = 0 V, f = 1 MHz	—	1650	_	
Output Capacitance	C <sub>oes</sub>		—	130	_	pF
Reverse Transfer Capacitance	C <sub>res</sub>		_	35	_	
Total Gate Charge	Qg	$V_{CE} = 400 \text{ V}, V_{GE} = 15 \text{ V}$ $I_{C} = 30.0 \text{ A}$	_	76	_	
Gate-Emitter Charge	Q <sub>ge</sub>		_	20	_	nC
Gate-Collector Charge	Q <sub>gc</sub>		_	38	_	

## IGBT Switching Characteristics (Inductive Load, T<sub>C</sub> = 25 °C, unless otherwise specified)

Parameter	Symbol	Conditions	Value			Unit
			Min.	Тур.	Max.	Unit
Turn-on Delay Time	t <sub>d(on)</sub>	$V_{CE}$ = 400 V, $V_{GE}$ = 15 V I <sub>C</sub> = 30.0 A, R <sub>G</sub> = 10 Ω	_	30	_	ns
Current Rise Time	t <sub>r</sub>		_	105	_	ns
Turn-off Delay Time	t <sub>d(off)</sub>		_	67	_	ns
Current Fall Time	t <sub>f</sub>		_	100	_	ns
Turn-on Switching Energy	Eon		_	1.85	_	mJ
Turn-off Switching Energy	E <sub>off</sub>		_	0.45	_	mJ
Total Switching Energy	E <sub>ts</sub>		_	2.3	_	mJ

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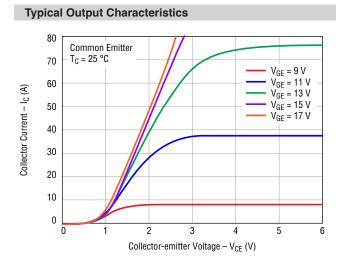
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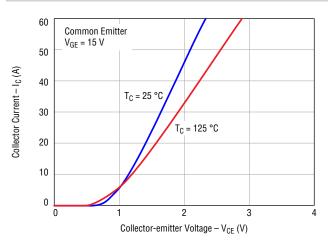
## Diode Switching Characteristics (T<sub>C</sub> = 25 °C, unless otherwise specified)

Parameter	Symbol	Conditions	Value			Unit
Parameter		Conditions	Min.	Тур.	Max.	Unit
Reverse Recovery Time	t <sub>rr</sub>	dl <sub>F</sub> /dt = 200 A/µs	—	40	_	ns
Reverse Recovery Charge	Q <sub>rr</sub>	I <sub>F</sub> = 30.0 A	—	90	_	nC

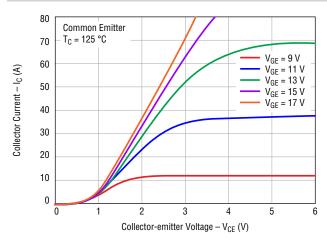
### **Electrical Characteristic Performance**



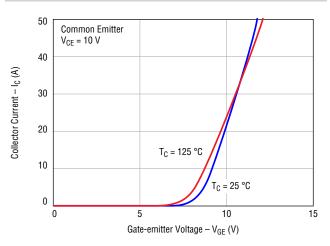
**Typical Saturation Voltage Characteristics** 



### **Typical Output Characteristics**



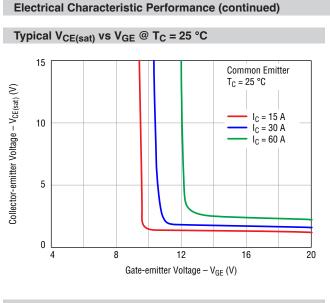
### **Typical Transfer Characteristics**

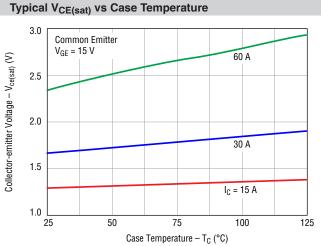


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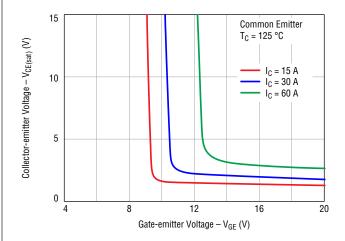
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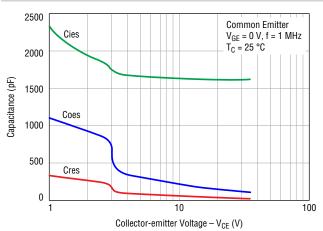




### Typical V<sub>CE(sat)</sub> vs V<sub>GE</sub> @ T<sub>C</sub> = 125 °C



### **Typical Capacitance Characteristics**



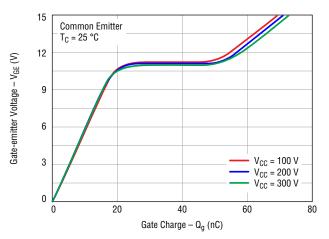
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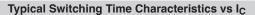
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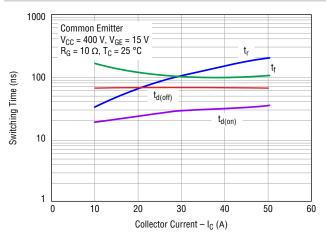
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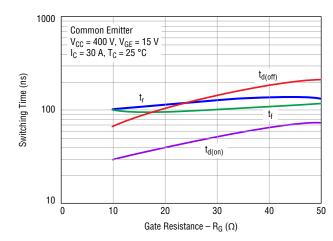
#### **Electrical Characteristic Performance (continued)**

## Typical Gate Charge Characteristics

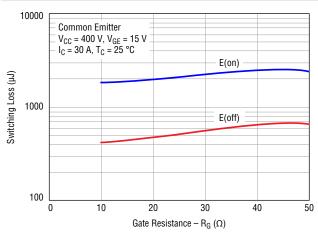










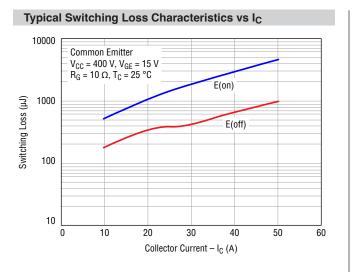


Typical Switching Time Characteristics vs  $\ensuremath{\mathsf{R}_{\mathsf{G}}}$ 

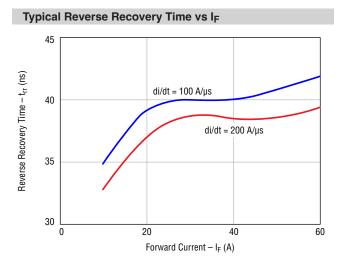
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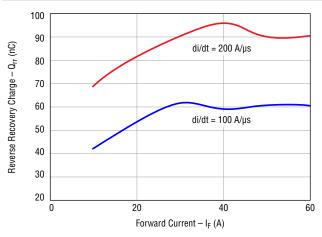


**Electrical Characteristic Performance (continued)** 



### Typical Diode I<sub>F</sub> vs V<sub>F</sub> 100 $T_{C} = 125 °C$ $T_{C} = 25 °C$ 10 $T_{C} = 25 °C$ 10 $T_{C} = 25 °C$ $T_{C} = 25 °C$

## Typical Reverse Recovery Charge vs I<sub>F</sub>



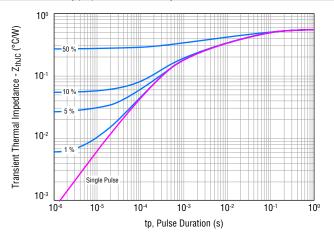
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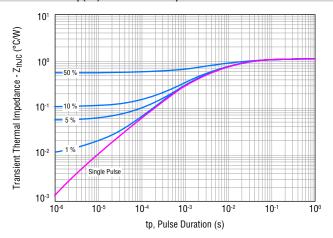
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**Electrical Characteristic Performance (continued)** 

IGBT Transient Thermal Impedance vs tp(on) Duration (D=tp/T)



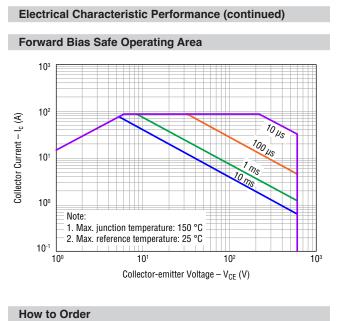
## Diode Transient Thermal Impedance vs $t_{p(on)}$ Duration (D= $t_p/T$ )

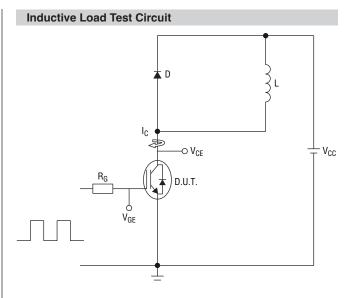


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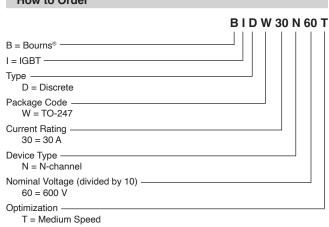




L = 1.87 mH, V\_{CE} = 400 V, V\_{GE} = 15 V, I\_{C} = 30 A, R\_G = 10  $\Omega$ 

## **Environmental Characteristics**

ESD Class (HBM)2
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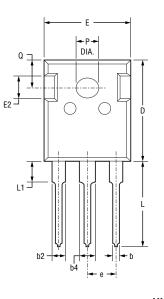


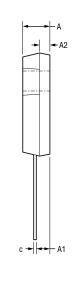
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#### **Product Dimensions**





DIMENSIONS:  $\frac{MM}{(INCHES)}$ 

#### Packaging Specifications

BIDW30N60T ...... 30 pieces per tube

Symbol	Min.	Nom.	Max.		
A	<u>4.80</u>	<u>5.00</u>	<u>5.20</u>		
	(.189)	(.197)	(.205)		
A1	<u>2.21</u>	<u>2.41</u>	<u>2.59</u>		
	(.087)	(.095)	(.102)		
A2	<u>1.85</u>	<u>2.00</u>	<u>2.15</u>		
	(.073)	(.079)	(.085)		
b	<u>1.11</u> (.044)	_	<u>1.36</u> (.054)		
b2	<u>1.91</u> (.075)	_	<u>2.25</u> (.089)		
b4	<u>2.91</u> (.115)	_	<u>3.25</u> (.128)		
с	<u>0.51</u> (.020)	_	<u>0.75</u> (.030)		
D	<u>20.80</u>	<u>21.00</u>	<u>21.30</u>		
	(.819)	(.827)	(.839)		
E	<u>15.50</u>	<u>15.80</u>	<u>16.10</u>		
	(.610)	(.622)	(.634)		
E2	<u>4.40</u>	<u>5.00</u>	<u>5.20</u>		
	(.173)	(.197)	(.205)		
е		<u>5.44</u> (.214) BSC			
L	<u>19.72</u>	<u>19.92</u>	<u>20.22</u>		
	(.776)	(.784)	(.796)		
L1	_	_	<u>4.30</u> (.169)		
Р	<u>3.40</u> (.134)	_	<u>3.80</u> (.150)		
Q	<u>5.60</u>	<u>5.80</u>	<u>6.00</u>		
	(.220)	(.228)	(.236)		

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